Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	4182	382/141-152.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:35
S2	508	382/141-152.ccls. and electron near2 beam	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 19:35
S3	155	382/141-152.ccls. and (electron near2 beam) and (height)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 19:36
S4	96	382/141-152.ccls. and (electron near2 microscope) and (height)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 20:04
S5	389	382/141-152.ccls. and (electron near2 microscope)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 19:36
S6	376	382/141-152.ccls. and (electron near2 microscope) and (height pattern shape)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 19:36
S7	362	382/141-152.ccls. and (electron near2 microscope) and (pattern)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 19:37
S8	265	382/141-152.ccls. and (electron near2 microscope) and (shape)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 19:37

S9	152	382/141-152.ccls. and (electron near2 microscope) and (cross near3 section\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 20:04
S10	152	382/141-152.ccls. and (electron near2 microscope) and (cross near2 section\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 21:19
S11	15	("5283442" "5345309" "5877092" "5939765" "6000281" "6009255" "6034409" "6096629" "6181411" "6392749" "6405153" "6476398" "6563586" "6849363").PN. OR ("6980937").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/03/07 21:16
S12	5	382/154.ccls. and (electron near2 microscope) and (cross near2 section\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 21:35
S13	19	382/154.ccls. and (electron near2 microscope)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 22:05
S14	16678	(cross near2 section) and (electron near2 microscope)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 22:06
S15	3888	(cross near2 section) and (electron near2 microscope) and (3D (three near2 dimension\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 22:07
S16	3181	(cross near2 section) and (electron near2 microscope) and ((three near2 dimension\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:40
S17	52	(cross near2 section) and (electron near2 microscope) and ((three near2 dimension\$4)) and scatterometry	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/07 22:07

S18	1728	382/154.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:35
· S19	234	382/154.ccls. and (cross near2 section)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:39
S20	1449	(cross near2 section) and (electron near2 microscope) and ((three near2 dimension\$4)) and height	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:41
S21	742	(cross near2 section) and (electron near2 microscope) and ((three near2 dimension\$4)) and height and semiconductor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:46
S22	103	(cross near2 section) same (electron near2 microscope) same ((three near2 dimension\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 11:42
S23	179	(cross near2 section) and (electron near2 microscope) and ((three near2 dimension\$4) same height) and semiconductor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 14:09
S24	0	"09132220".ap.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 12:17
S25	21	(cross near2 section) and (electron near2 microscope) and ((three near2 dimension\$4) same height) and semiconductor and stereo\$7	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/03/08 14:10
S26	110	382/141-152.ccls. and (electron near2 microscope) and (height)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/09/13 13:35

S27	167	382/141-152.ccls. and (electron near2 microscope) and (cross near3 section\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/09/13 13:36
S28	20	382/154.ccls. and (electron near2 microscope)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/09/13 13:36
S29	5	382/154.ccls. and (electron near2 microscope) and (cross near2 section\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2007/09/13 13:36